Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

2SK3444

Switching Regulator, DC-DC Converter Applications Motor Drive Applications

- Low drain-source ON resistance: RDS (ON) = 65 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 10 \text{ S (typ.)}$
- Low leakage current: $IDSS = 100 \mu A (VDS = 200 V)$
- Enhancement mode: $V_{th} = 3.0 \text{ to } 5.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	200	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	200	V	
Gate-source voltage		V _{GSS}	±30	V	
Drain current	DC (Note 1)	I _D	25	Α	
	Pulse (Note 1)	I _{DP}	100		
Drain power dissipation (Tc = 25°C)		P _D	125	W	
Single pulse avalanche energy (Note 2)		E _{AS}	488	mJ	
Avalanche current		I _{AR}	25	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	12.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55 to 150	°C	

92 max 70±02 4 92 max 70±02 4 92 0.4±0.1 1.2 1.2 1.2 1.0±0.21,0±0.2 3.8 ± 0.2 4 1.0±0.21,0±0.2

2-9F1B

Weight: 0.74 g (typ.)

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Thermal Characteristics

Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to case	R _{th (ch-c)}	1.00	°C/W	

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_{DD} = 50 V, T_{ch} = 25°C (initial), L = 1.26 mH, I_{AR} = 25 A, R_G = 25 Ω

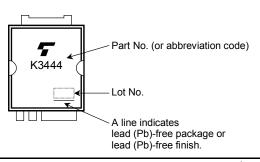
Note 3: Repetitive rating: pulse width limited by maximum channel temperature

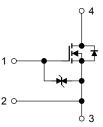
This transistor is an electrostatic-sensitive device. Please handle with caution.

Notice: Please i

Please use the S1 pin for gate input signal return. Make sure that the main current flows into the S2 pin.

Marking







Electrical Characteristics (Note 4) (Ta = 25°C)

Cha	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Drain cut-off curre	ent	I _{DSS}	V _{DS} = 200 V, V _{GS} = 0 V	_	_	100	μА
Drain-source brea	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	200	_	_	V
Gate threshold vo	oltage	V _{th}	$V_{DS} = 10 \text{ V}, I_{D} = 1 \text{ mA}$	3.0	_	5.0	V
Drain-source ON	resistance	R _{DS (ON)}	$V_{GS} = 10 \text{ V}, I_D = 12.5 \text{ A}$	_	65	82	mΩ
Forward transfer	admittance	Y _{fs}	$V_{DS} = 10 \text{ V}, I_D = 12.5 \text{ A}$	5	10	_	S
Input capacitance		C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	2080	_	pF
Reverse transfer capacitance		C _{rss}		_	280	_	
Output capacitance		C _{oss}		_	1060	_	
Switching time	Rise time	t _r	V _{GS} 10 V	-	20		- ns
	Turn-on time	t _{on}		_	40	_	
	Fall time	t _f		_	10	_	
	Turn-off time	t _{off}	$V_{DD} \simeq 100 \text{ V}$ Duty $\leq 1\%$, $t_W = 10 \mu \text{s}$	_	40	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq 160 \text{ V}, V_{GS} = 10 \text{ V},$	_	44	_	nC
Gate-source charge		Q _{gs}	$I_D = 25 \text{ A}$	_	21	_	
Gate-drain ("miller") charge		Q _{gd}		_	23	_	

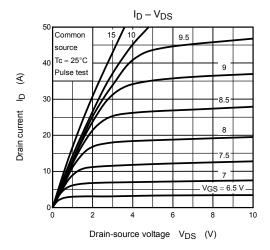
Note 4: Connect the S1 pin and S2 pin together, and ground them except during switching time measurement.

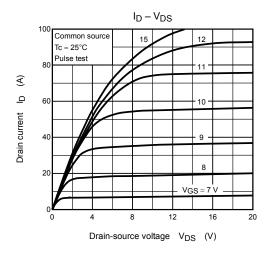
Source-Drain Diode Ratings and Characteristics (Note 5) (Ta = 25°C)

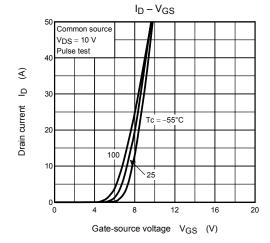
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1, Note 5)	I _{DR} 1	_	_	_	25	Α
Pulse drain reverse current (Note 1, Note 5)	I _{DRP} 1	_	ı		100	Α
Continuous drain reverse current (Note 1, Note 5)	I _{DR} 2	_			1	A
Pulse drain reverse current (Note 1, Note 5)	I _{DRP} 2	_	-	_	4	Α
Forward voltage (diode)	V _{DS2F}	$I_{DR1} = 25 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.5	V
Reverse recovery time	t _{rr}	$I_{DR} = 25 \text{ A}, V_{GS} = 0 \text{ V},$ $dI_{DR}/dt = 100 \text{ A}/\mu\text{s}$	_	290	_	ns
Reverse recovery charge	Q _{rr}	$dI_{DR}/dt = 100 \text{ A/}\mu\text{s}$		2.2	_	μС

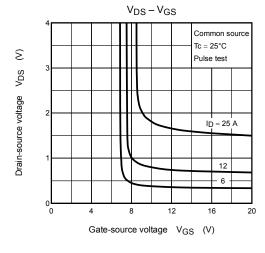
Note 5: $I_{DR}1$, $I_{DRP}1$: Current flowing between the drain and the S2 pin. Ensure that the S1 pin is left open. $I_{DR}2$, $I_{DRP}2$: Current flowing between the drain and the S1 pin. Ensure that the S2 pin is left open.

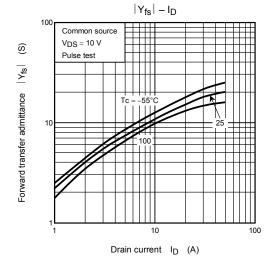
Unless otherwise specified, connect the S1 and S2 pins together, and ground them.

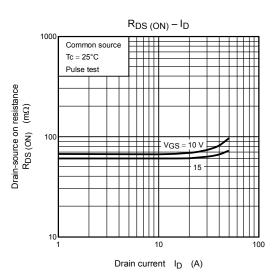


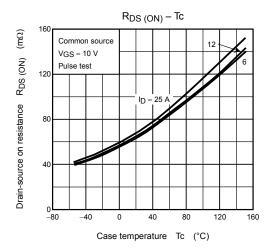


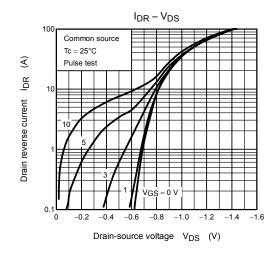


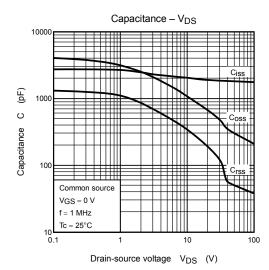


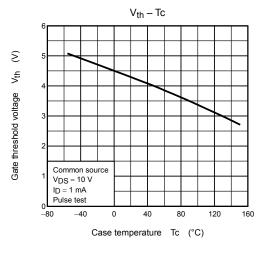


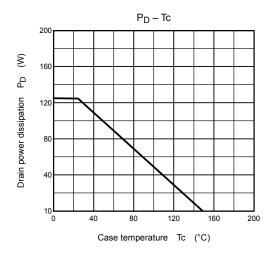


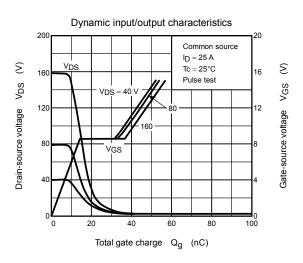




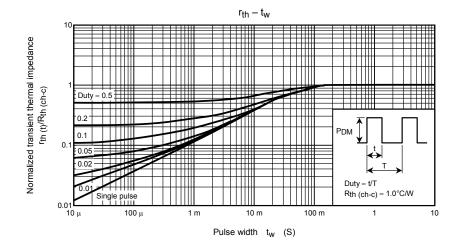


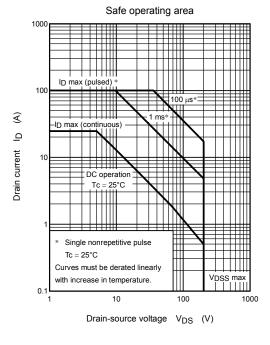


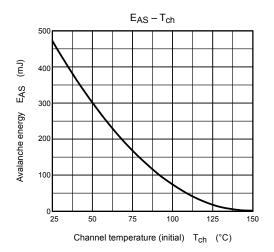


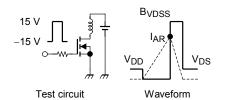


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$$R_G = 25~\Omega$$

$$V_{DD} = 50~V,~L = 1.26~mH$$

$$\mathsf{EAS} = \frac{1}{2} \cdot L \cdot l^2 \cdot \left(\frac{\mathsf{BVDSS}}{\mathsf{BVDSS} - \mathsf{VDD}} \right)$$

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